

**Search Notes**

Application/Control No.

09/990,558

Examiner

John L. Shew

Applicant(s)/Patent under  
Reexamination

CHOI ET AL.

Art Unit

2616

**SEARCHED**

Class	Subclass	Date	Examiner
370	320,329	3/27/2006	JS
	331,332		
	335,336		
	337,342		
	348,349		
	437,441		
455	432.1	3/28/2006	JS
	432.3		
	433,436		
	439,442		
	450,452		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR